Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/645,516	ONO ET AL.
Examiner .	Art Unit
José R. Díaz	2815

SEARCHED			
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Class	Subclass	Date	Examiner
438	149, 163, 164, 514, 517	2/19/2005	JRD
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Text Search: East (see attachment)	2/19/2005	JRD	